Applicant(s)/Patent Under Application/Control No. Reexamination 10/676,067 MATSUEDA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Dieu Hien T. Duong 2821 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,633,135 10-2003 Nara et al. 315/169.3 US-2003/0076046 04-2003 315/169.3 В Komiya et al. US-С US-D US-E US-US-G US-Н US-1 US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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